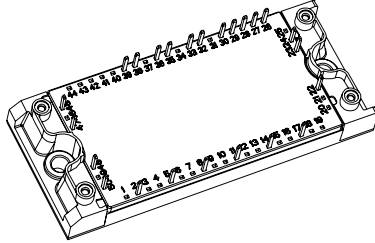


## IGBT PIM Module, 17 A


**ECONO2 PIM**
**FEATURES**

- Low  $V_{CE(on)}$  non punch through IGBT technology
- Low diode  $V_F$
- 10  $\mu$ s short circuit capability
- Square RBSOA
- HEXFRED® antiparallel diode with ultrasoft reverse recovery characteristics
- Positive  $V_{CE(on)}$  temperature coefficient
- Ceramic DBC substrate
- Low stray inductance design
- Speed 8 to 60 kHz
- Totally lead (Pb)-free
- Designed and qualified for industrial market


**RoHS**  
COMPLIANT

PRODUCT SUMMARY	
$V_{CES}$	600 V
$V_{CE(on)}$ (typical)	1.87 V
$t_{sc}$ at $T_J = 150\text{ }^\circ\text{C}$	> 10 $\mu$ s
$I_C$ at $T_C = 80\text{ }^\circ\text{C}$	17 A

**BENEFITS**

- Benchmark efficiency for motor control
- Rugged transient performance
- Low EMI, requires less snubbing
- Direct mounting to heatsink
- PCB solderable terminals
- Low junction to case thermal resistance
- UL approved E78996

ABSOLUTE MAXIMUM RATINGS						
	PARAMETER	SYMBOL	TEST CONDITIONS		MAX.	UNITS
Inverter	Collector to emitter voltage	$V_{CES}$			600	V
	Gate to emitter voltage	$V_{GES}$			$\pm 20$	
	Continuous collector current	$I_C$	$T_C = 25\text{ }^\circ\text{C}$		25	A
			$T_C = 80\text{ }^\circ\text{C}$		17	
	Pulsed collector current See fig. C.T.5	$I_{CM}$			50	A
	Diode maximum forward current	$I_{FM}$	Pulsed		50	A
Power dissipation	$P_D$	One IGBT	25 $^\circ\text{C}$	100	W	
Input rectifier	Repetitive peak reverse voltage	$V_{RRM}$			800	V
	Average output current	$I_{F(AV)}$	50/60 Hz sine pulse	80 $^\circ\text{C}$	15	A
	Surge current (non-repetitive)	$I_{FSM}$	Rated $V_{RRM}$ applied, 10 ms, sine pulse		310	
	$I^2t$ (non-repetitive)	$I^2t$			525	A <sup>2</sup> s
Brake	Collector to emitter voltage	$V_{CES}$			600	V
	Gate to emitter voltage	$V_{GES}$			$\pm 20$	
	Continuous collector current	$I_C$	$T_C = 25\text{ }^\circ\text{C}$		15	A
			$T_C = 80\text{ }^\circ\text{C}$		9	
	Pulsed collector current See fig. C.T.5	$I_{CM}$			30	A
	Power dissipation	$P_D$	One IGBT	25 $^\circ\text{C}$	100	W
	Repetitive peak reverse voltage	$V_{RRM}$			600	V
	Maximum operating junction temperature	$T_J$			150	$^\circ\text{C}$
	Storage temperature range	$T_{Sig}$			- 40 to + 125	
Isolation voltage	$V_{ISOL}$	AC (1 min)		2500		

ELECTRICAL SPECIFICATIONS (T <sub>J</sub> = 25 °C unless otherwise noted)							
	PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Inverter IGBT	Collector to emitter breakdown voltage	BV <sub>(CES)</sub>	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 500 μA	600	-	-	V
	Temperature coefficient of breakdown voltage	ΔV <sub>(BR)CES</sub> /ΔT <sub>J</sub>	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA (25 °C to 125 °C)	-	0.6	-	V/°C
	Collector to emitter voltage	V <sub>CE(on)</sub>	I <sub>C</sub> = 15 A, V <sub>GE</sub> = 15 V	-	1.87	2.20	V
			I <sub>C</sub> = 25 A, V <sub>GE</sub> = 15 V	-	2.33	2.75	
			I <sub>C</sub> = 15 A, V <sub>GE</sub> = 15 V, T <sub>J</sub> = 125 °C	-	2.16	2.42	
			I <sub>C</sub> = 25 A, V <sub>GE</sub> = 15 V, T <sub>J</sub> = 125 °C	-	2.78	3.17	
	Gate threshold voltage	V <sub>GE(th)</sub>	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250 μA	4	-	6	
	Threshold voltage temperature coefficient	ΔV <sub>GE(th)</sub> /ΔT <sub>J</sub>	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 1 mA (25 °C to 125 °C)	-	- 10	-	mV/°C
	Zero gate voltage collector current	I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 600 V	-	-	100	μA
			V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 600 V T <sub>J</sub> = 125 °C	-	250	-	
	Gate to emitter leakage current	I <sub>GES</sub>	V <sub>GE</sub> = ± 20 V	-	-	± 200	nA
	Total gate charge (turn-on)	Q <sub>G</sub>	I <sub>C</sub> = 15 A	-	53	80	nC
	Gate to emitter charge (turn-on)	Q <sub>GE</sub>	V <sub>CC</sub> = 300 V V <sub>GE</sub> = 15 V	-	14	21	
	Gate to collector charge (turn-on)	Q <sub>GC</sub>		-	18	27	
	Turn-on switching loss	E <sub>on</sub>	I <sub>C</sub> = 15 A, V <sub>CC</sub> = 300 V	-	0.27	0.41	mJ
	Turn-off switching loss	E <sub>off</sub>	V <sub>GE</sub> = 15 V, R <sub>G</sub> = 22 Ω L = 200 μH, T <sub>J</sub> = 25 °C <sup>(1)</sup>	-	0.15	0.23	
	Total switching loss	E <sub>tot</sub>		-	0.42	0.64	
	Turn-on switching loss	E <sub>on</sub>	I <sub>C</sub> = 15 A, V <sub>CC</sub> = 300 V	-	0.36	0.54	
	Turn-off switching loss	E <sub>off</sub>	V <sub>GE</sub> = 15 V, R <sub>G</sub> = 22 Ω L = 200 μH, T <sub>J</sub> = 125 °C <sup>(1)</sup>	-	0.25	0.38	
	Total switching loss	E <sub>tot</sub>		-	0.61	0.92	
	Turn-on delay time	t <sub>d(on)</sub>	I <sub>C</sub> = 15 A, V <sub>CC</sub> = 300 V	-	87	131	ns
	Rise time	t <sub>r</sub>	V <sub>GE</sub> = 15 V, R <sub>G</sub> = 22 Ω L = 200 μH, T <sub>J</sub> = 125 °C	-	22	33	
	Turn-off delay time	t <sub>d(off)</sub>		-	112	168	
Fall time	t <sub>f</sub>		-	119	179		
Input capacitance	C <sub>ies</sub>	V <sub>GE</sub> = 0 V	-	901	1352	pF	
Output capacitance	C <sub>oes</sub>	V <sub>CC</sub> = 30 V	-	263	395		
Reverse transfer capacitance	C <sub>res</sub>	f = 1 MHz	-	29	44		
Inverter IGBT	Reverse bias safe operating area	RBSOA	T <sub>J</sub> = 125 °C, I <sub>C</sub> = 50 A R <sub>G</sub> = 22 Ω, V <sub>GE</sub> = 15 V to 0	Fullsquare			
	Short circuit safe operating area	SCSOA	T <sub>J</sub> = 150 °C V <sub>CC</sub> = 300 V, V <sub>P</sub> = 600 V R <sub>G</sub> = 22 Ω, V <sub>GE</sub> = 15 V to 0 V	10	-	-	μs
Inverter Diode	Diode peak reverse recovery current	I <sub>rr</sub>	T <sub>J</sub> = 125 °C V <sub>CC</sub> = 300 V, I <sub>F</sub> = 15 A, L = 200 μH R <sub>G</sub> = 22 Ω, V <sub>GE</sub> = 15 V	-	30	-	A
	Diode forward voltage drop	V <sub>FM</sub>	I <sub>F</sub> = 15 A	-	1.22	1.38	V
			I <sub>F</sub> = 25 A	-	1.36	1.61	
			I <sub>F</sub> = 15 A, T <sub>J</sub> = 125 °C	-	1.17	1.37	
I <sub>F</sub> = 25 A, T <sub>J</sub> = 125 °C			-	1.34	1.65		



ELECTRICAL SPECIFICATIONS (T <sub>J</sub> = 25 °C unless otherwise noted)							
	PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Input Rectifier	Maximum forward voltage drop	V <sub>FM</sub>	I <sub>F</sub> = 15 A	-	-	1.15	V
	Maximum reverse leakage current	I <sub>RM</sub>	T <sub>J</sub> = 25 °C, V <sub>R</sub> = 800 V	-	-	0.2	mA
			T <sub>J</sub> = 150 °C, V <sub>R</sub> = 800 V	-	-	1	
	Forward slope resistance	r <sub>T</sub>	T <sub>J</sub> = 150 °C	-	10.2	-	mΩ
Conduction threshold voltage	V <sub>F(TO)</sub>	-		0.74	-		
Brake IGBT	Collector to emitter breakdown voltage	BV <sub>(CES)</sub>	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 500 μA	600	-	-	V/°C
	Temperature coefficient of breakdown voltage	ΔV <sub>(BR)CES</sub> /ΔT <sub>J</sub>	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA (25 °C to 125 °C)	-	0.6	-	
	Collector to emitter voltage	V <sub>CE(on)</sub>	I <sub>C</sub> = 10 A, V <sub>GE</sub> = 15 V	-	1.69	2.00	V
			I <sub>C</sub> = 15 A, V <sub>GE</sub> = 15 V	-	1.86	2.19	
			I <sub>C</sub> = 10 A, V <sub>GE</sub> = 15 V, T <sub>J</sub> = 125 °C	-	1.84	2.19	
			I <sub>C</sub> = 15 A, V <sub>GE</sub> = 15 V, T <sub>J</sub> = 125 °C	-	2.15	2.45	
	Gate threshold voltage	V <sub>GE(th)</sub>	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250 μA	4	-	6	mV/°C
	Threshold voltage temperature coefficient	ΔV <sub>GE(th)</sub> /ΔT <sub>J</sub>	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 1 mA (25 °C to 125 °C)	-	- 10	-	
	Zero gate voltage collector current	I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 600 V	-	-	100	μA
			V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 600 V, T <sub>J</sub> = 125 °C	-	200	-	
	Gate to emitter leakage current	I <sub>GES</sub>	V <sub>GE</sub> = ± 20 V	-	-	± 200	nA
	Total gate charge (turn-on)	Q <sub>G</sub>	I <sub>C</sub> = 10 A, V <sub>CC</sub> = 300 V, V <sub>GE</sub> = 15 V	-	53	80	nC
	Gate to emitter charge (turn-on)	Q <sub>GE</sub>		-	12	18	
	Gate to collector charge (turn-on)	Q <sub>GC</sub>		-	18	27	
	Turn-on switching loss	E <sub>on</sub>	I <sub>C</sub> = 10 A, V <sub>CC</sub> = 300 V, V <sub>GE</sub> = 15 V, R <sub>G</sub> = 22 Ω, L = 500 μH, T <sub>J</sub> = 25 °C <sup>(1)</sup>	-	0.14	0.21	mJ
	Turn-off switching loss	E <sub>off</sub>		-	0.11	0.16	
	Total switching loss	E <sub>tot</sub>		-	0.25	0.37	
	Turn-on switching loss	E <sub>on</sub>	I <sub>C</sub> = 10 A, V <sub>CC</sub> = 300 V, V <sub>GE</sub> = 15 V, R <sub>G</sub> = 22 Ω, L = 500 μH, T <sub>J</sub> = 125 °C <sup>(1)</sup>	-	0.18	0.26	mJ
	Turn-off switching loss	E <sub>off</sub>		-	0.20	0.30	
Total switching loss	E <sub>tot</sub>	-		0.38	0.56		
Turn-on delay time	t <sub>d(on)</sub>	I <sub>C</sub> = 10 A, V <sub>CC</sub> = 300 V, V <sub>GE</sub> = 15 V, R <sub>G</sub> = 22 Ω, L = 500 μH, T <sub>J</sub> = 125 °C	-	86	130	ns	
Rise time	t <sub>r</sub>		-	17	26		
Turn-off delay time	t <sub>d(off)</sub>		-	117	176		
Fall time	t <sub>f</sub>		-	152	228		
Brake IGBT	Input capacitance	C <sub>ies</sub>	V <sub>GE</sub> = 0 V, V <sub>CC</sub> = 30 V, f = 1 MHz	-	901	1352	pF
	Output capacitance	C <sub>oes</sub>		-	263	395	
	Reverse transfer capacitance	C <sub>res</sub>		-	29	44	
	Reverse bias safe operating area	RBSOA	T <sub>J</sub> = 150 °C, I <sub>C</sub> = 30 A, R <sub>G</sub> = 22 Ω, V <sub>GE</sub> = 15 V to 0	Fullsquare			
	Short circuit safe operating area	SCSOA	T <sub>J</sub> = 150 °C, V <sub>CC</sub> = 300 V, V <sub>P</sub> = 600 V, R <sub>G</sub> = 22 Ω, V <sub>GE</sub> = 15 V to 0	10	-	-	μs

<b>ELECTRICAL SPECIFICATIONS</b> ( $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted)							
	PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Brake Diode	Diode peak reverse recovery current	$I_{rr}$	$V_{CC} = 300\text{ V}$ , $I_F = 10\text{ A}$ , $L = 500\text{ }\mu\text{H}$ $V_{GE} = 15\text{ V to }0$ , $R_G = 22\text{ }\Omega$	-	-	-	A
	Diode forward voltage drop	$V_{FM}$	$I_F = 10\text{ A}$	-	1.34	1.43	V
			$I_F = 15\text{ A}$	-	1.46	1.75	
			$I_F = 10\text{ A}$ , $T_J = 125\text{ }^\circ\text{C}$	-	1.28	1.39	
			$I_F = 15\text{ A}$ , $T_J = 125\text{ }^\circ\text{C}$	-	1.43	1.59	
NTC	Resistance	R	$T_J = 25\text{ }^\circ\text{C}$	-	5000	-	$\Omega$
			$T_J = 100\text{ }^\circ\text{C}$	-	4933	-	
	B value	B	$T_J = 25\text{ }^\circ\text{C}/50\text{ }^\circ\text{C}$	-	3375	-	K

**Note**

(1) Energy losses include “tail” and diode reverse recovery

<b>THERMAL AND MECHANICAL SPECIFICATIONS</b>					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNITS
Junction to case inverter IGBT thermal resistance	$R_{thJC}$	-	-	1.25	$^\circ\text{C}/\text{W}$
Junction to case inverter FRED thermal resistance		-	-	2.13	
Junction to case brake DIODE thermal resistance		-	-	2.44	
Junction to case brake IGBT thermal resistance		-	-	1.25	
Junction to case input rectifier thermal resistance		-	-	1.03	
Case to sink, flat, greased surface	$R_{thCS}$	-	0.05	-	
Mounting torque (M5)		2.7	-	3.3	Nm
Weight		-	170	-	g

**INVERTER**

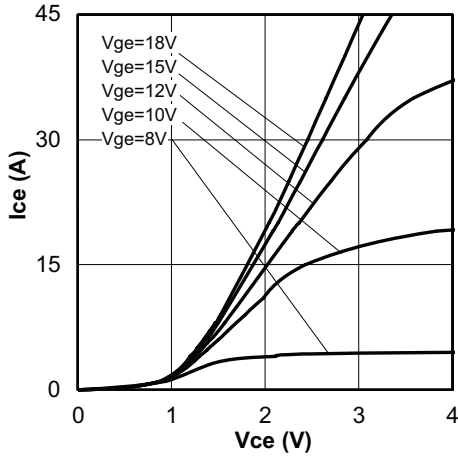


Fig. 1 - Typical IGBT Output Characteristics  
 $T_J = 25\text{ }^\circ\text{C}$ ;  $t_p = 80\text{ }\mu\text{s}$

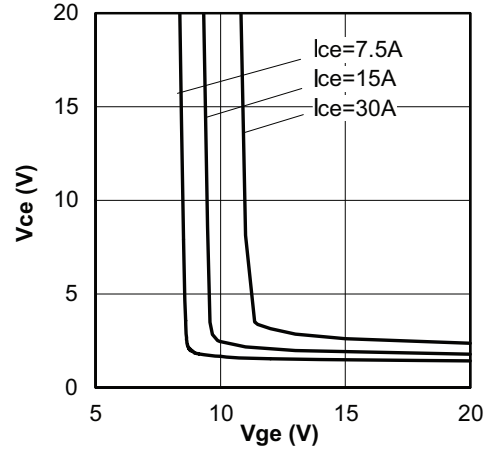


Fig. 4 - Typical  $V_{CE}$  vs.  $V_{GE}$   
 $T_J = 25\text{ }^\circ\text{C}$

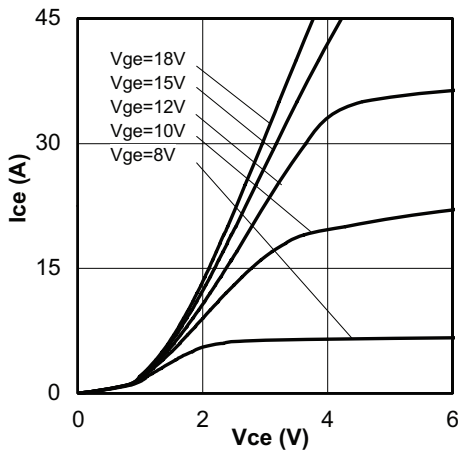


Fig. 2 - Typical IGBT Output Characteristics  
 $T_J = 125\text{ }^\circ\text{C}$ ;  $t_p = 80\text{ }\mu\text{s}$

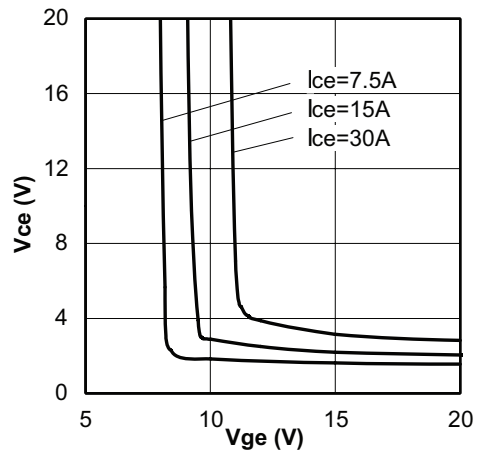


Fig. 5 - Typical  $V_{CE}$  vs.  $V_{GE}$   
 $T_J = 125\text{ }^\circ\text{C}$

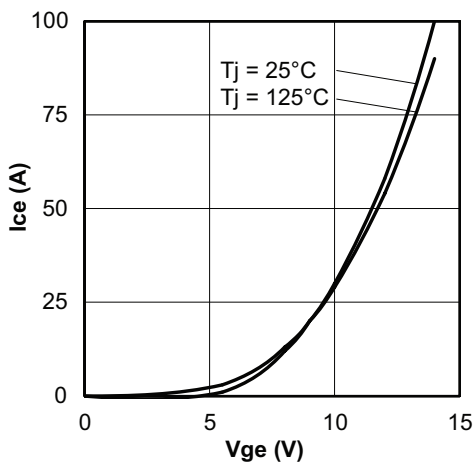


Fig. 3 - Typical Transfer Characteristics  
 $V_{CE} = 50\text{ V}$ ;  $t_p = 10\text{ }\mu\text{s}$

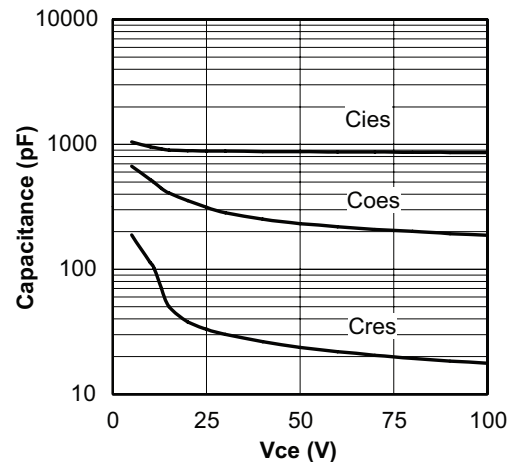


Fig. 6 - Typical Capacitance vs.  $V_{CE}$   
 $V_{GE} = 0\text{ V}$ ;  $f = 1\text{ MHz}$

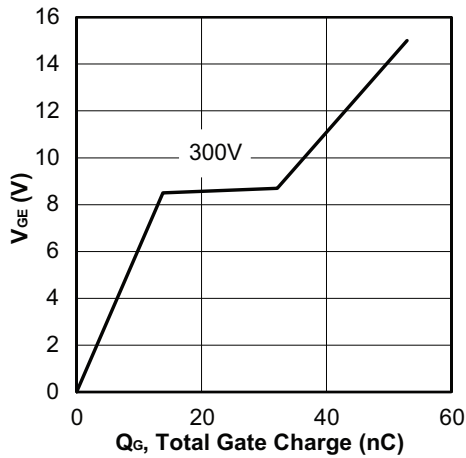


Fig. 7 - Typical Gate Charge vs.  $V_{GE}$   
 $I_{CE} = 15 \text{ A}$

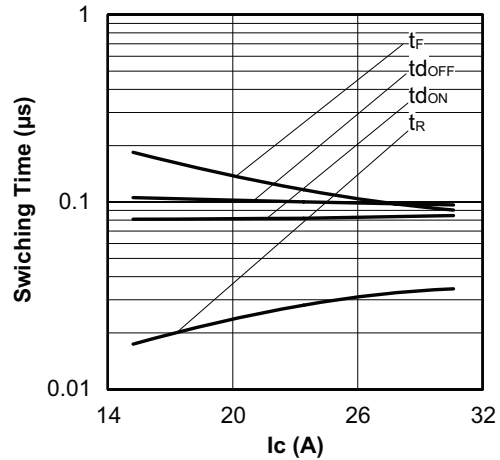


Fig. 10 - Typical Switching Time vs.  $I_C$   
 $T_J = 125^\circ\text{C}$ ;  $L = 200 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $R_G = 22 \Omega$ ;  $V_{GE} = 15 \text{ V}$

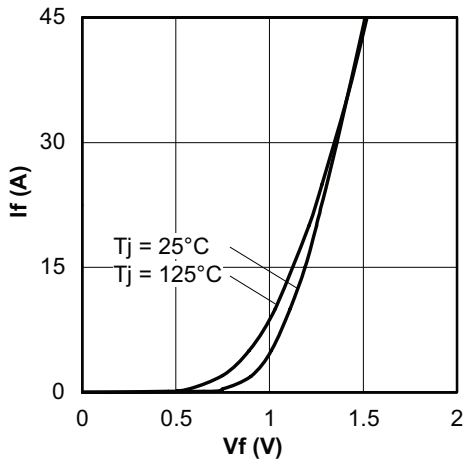


Fig. 8 - Typical Diode Forward Characteristics  
 $t_p = 80 \mu\text{s}$

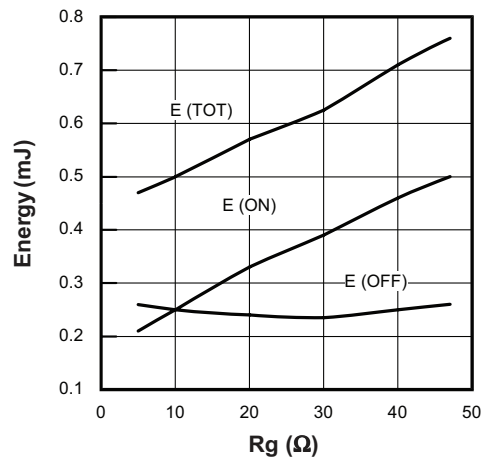


Fig. 11 - Typical Energy Loss vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $L = 200 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $I_{CE} = 15 \text{ A}$ ,  $V_{GE} = 15 \text{ V}$

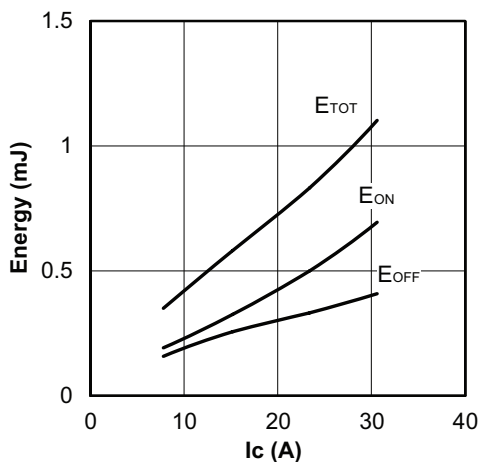


Fig. 9 - Typical Energy Loss vs.  $I_C$   
 $T_J = 125^\circ\text{C}$ ;  $L = 200 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $R_G = 22 \Omega$ ;  $V_{GE} = 15 \text{ V}$

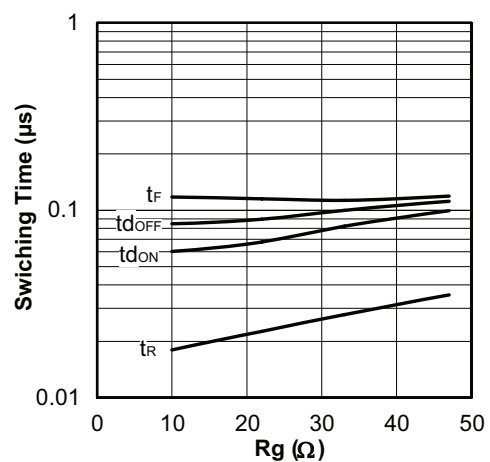


Fig. 12 - Typical Switching Time vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $L = 500 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $I_{CE} = 15 \text{ A}$ ,  $V_{GE} = 15 \text{ V}$

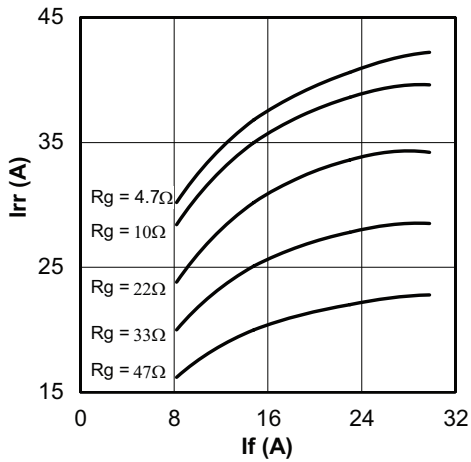
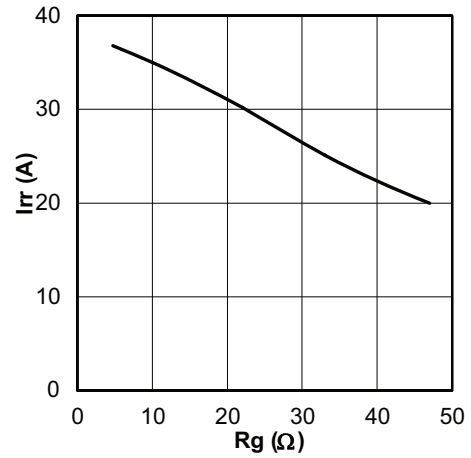
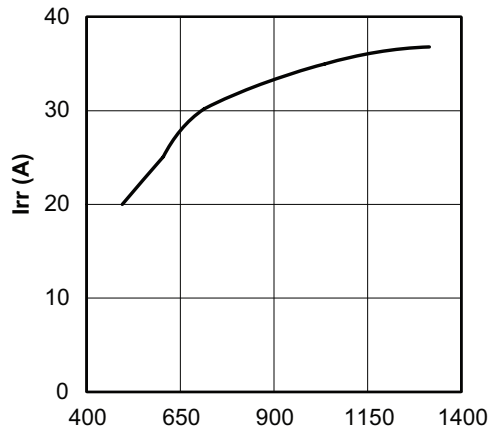
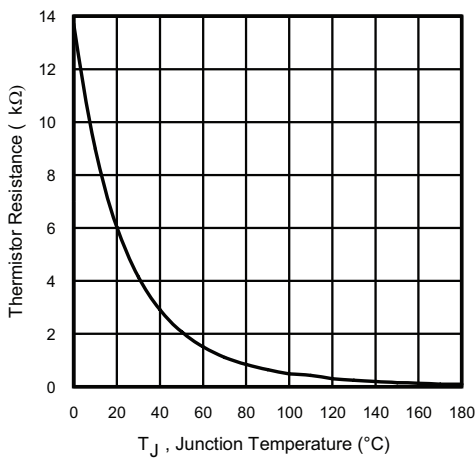
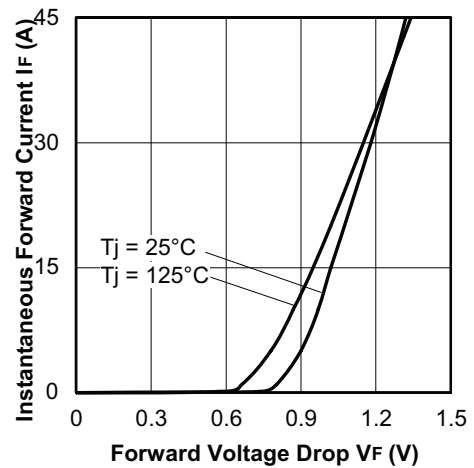

 Fig. 13 - Typical Diode  $I_{RR}$  vs.  $I_F$   
 $T_J = 125^\circ\text{C}$ 

 Fig. 14 - Typical Diode  $I_{RR}$  vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $I_F = 15\text{ A}$ 

 Fig. 15 - Typical Diode  $I_{RR}$  vs.  $dI_F/dt$   
 $V_{CC} = 300\text{ V}$ ;  $V_{GE} = 15\text{ V}$ ;  $I_{CE} = 15\text{ A}$ ;  $T_J = 125^\circ\text{C}$ 
**THERMISTOR**


Fig. 16 - Thermistor Resistance vs. Temperature

**INPUT RECTIFIER**

 Fig. 17 - Typical Diode Forward Characteristics  
 $t_p = 80\ \mu\text{s}$

**INVERTER**

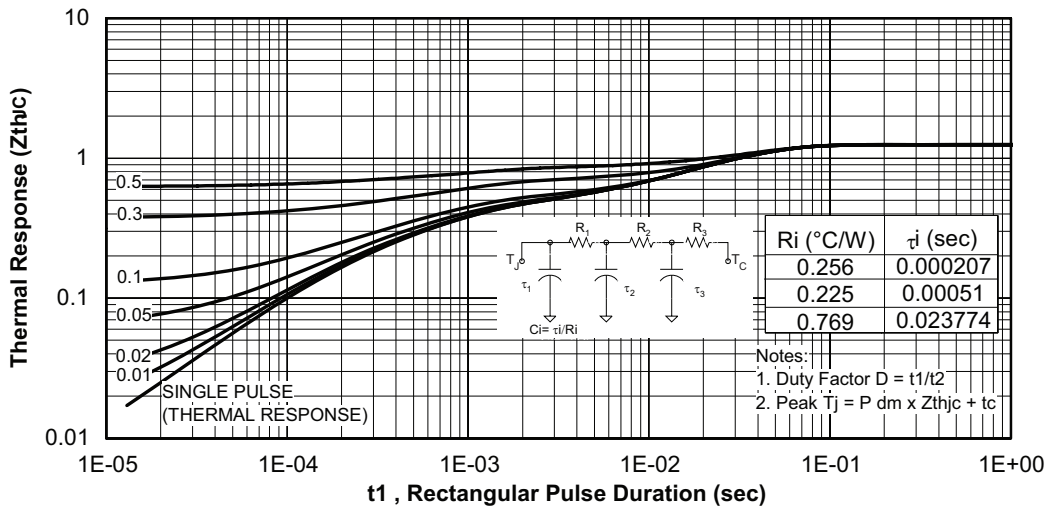


Fig. 18 - Maximum Transient Thermal Impedance, Junction to Case (Inverter IGBT)

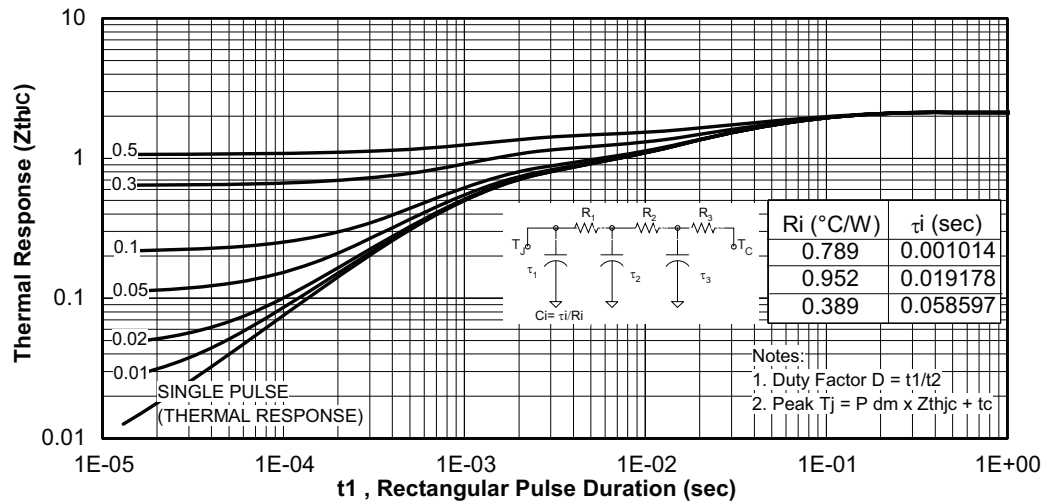
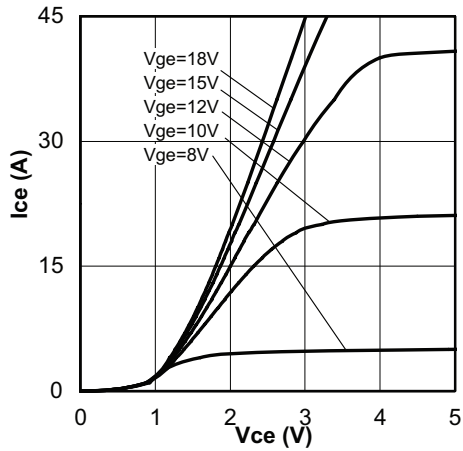
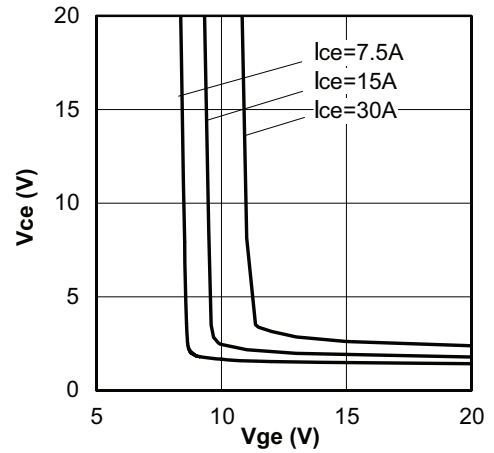
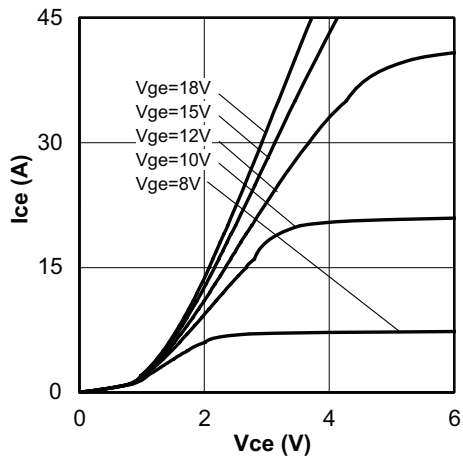
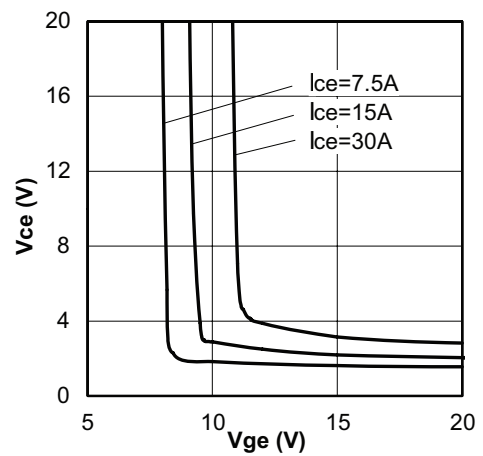
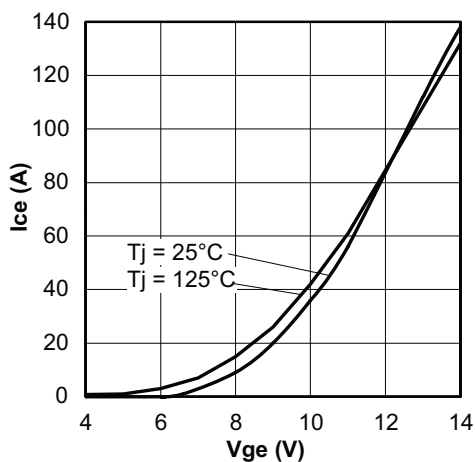
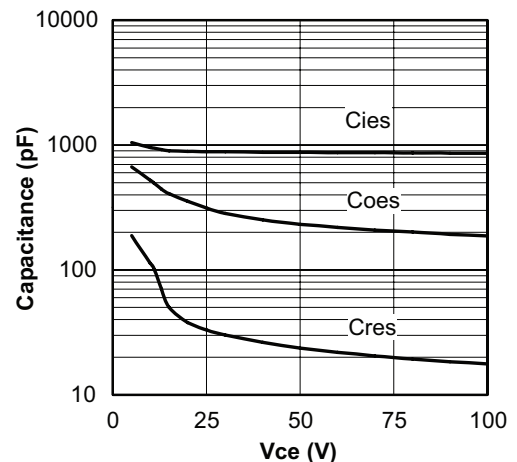


Fig. 19 - Maximum Transient Thermal Impedance, Junction to Case (Inverter FRED)



**BRAKE**

 Fig. 20 - Typical IGBT Output Characteristics  
 $T_J = 25\text{ }^\circ\text{C}$ ;  $t_p = 80\text{ }\mu\text{s}$ 

 Fig. 23 - Typical  $V_{CE}$  vs.  $V_{GE}$   
 $T_J = 25\text{ }^\circ\text{C}$ 

 Fig. 21 - Typical IGBT Output Characteristics  
 $T_J = 125\text{ }^\circ\text{C}$ ;  $t_p = 80\text{ }\mu\text{s}$ 

 Fig. 24 - Typical  $V_{CE}$  vs.  $V_{GE}$   
 $T_J = 125\text{ }^\circ\text{C}$ 

 Fig. 22 - Typical Transfer Characteristics  
 $V_{CE} = 50\text{ V}$ ;  $t_p = 10\text{ }\mu\text{s}$ 

 Fig. 25 - Typical Capacitance vs.  $V_{CE}$   
 $V_{GE} = 0\text{ V}$ ;  $f = 1\text{ MHz}$

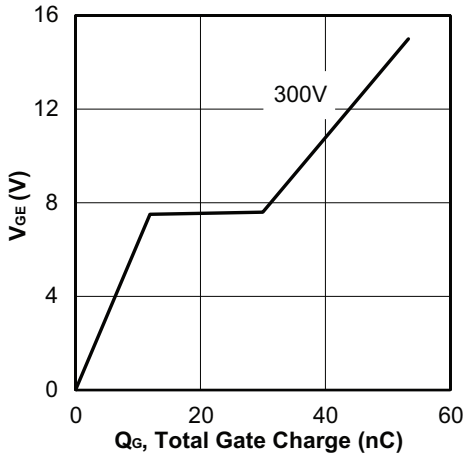


Fig. 26 - Typical Gate Charge vs.  $V_{GE}$   
 $I_{CE} = 5 \text{ A}$

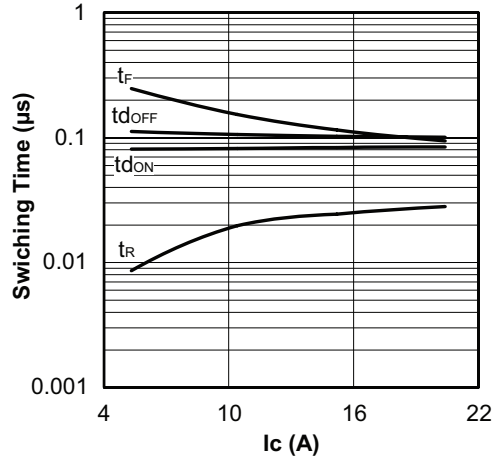


Fig. 29 - Typical Switching Time vs.  $I_C$   
 $T_J = 125^\circ\text{C}$ ;  $L = 200 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $R_G = 22 \Omega$ ;  $V_{GE} = 15 \text{ V}$

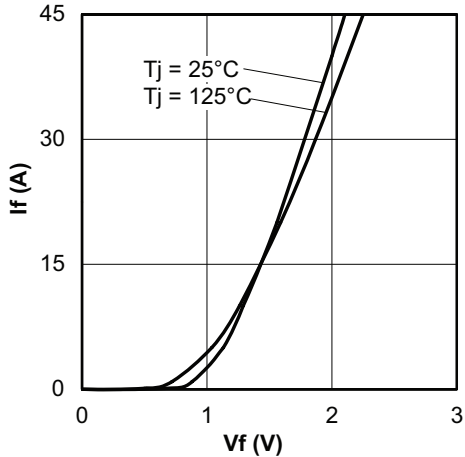


Fig. 27 - Typical Diode Forward Characteristics  
 $t_p = 80 \mu\text{s}$

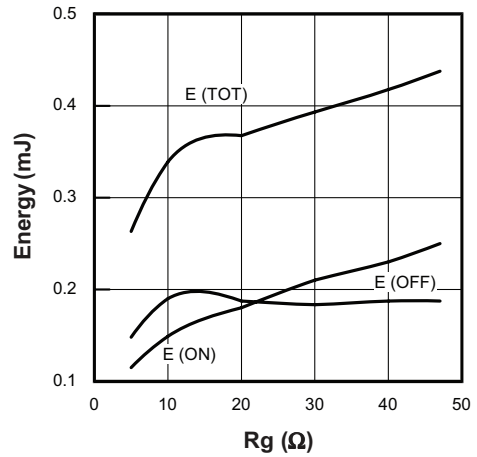


Fig. 30 - Typical Energy Loss vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $L = 200 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $I_{CE} = 10 \text{ A}$ ;  $V_{GE} = 15 \text{ V}$

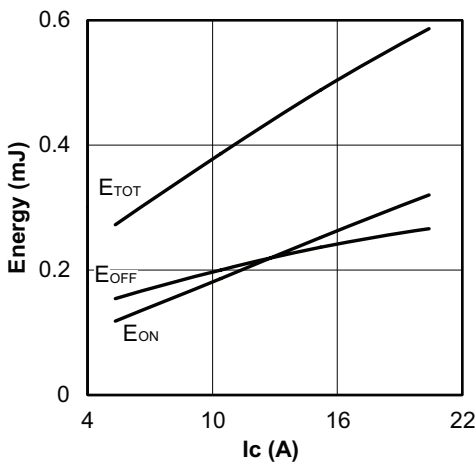


Fig. 28 - Typical Energy Loss vs.  $I_C$   
 $T_J = 125^\circ\text{C}$ ;  $L = 200 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $R_G = 22 \Omega$ ;  $V_{GE} = 15 \text{ V}$

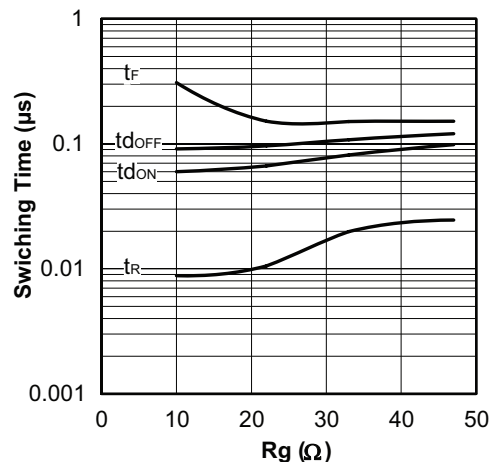


Fig. 31 - Typical Switching Time vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $L = 200 \mu\text{H}$ ;  $V_{CE} = 300 \text{ V}$ ;  $I_{CE} = 10 \text{ A}$ ;  $V_{GE} = 15 \text{ V}$

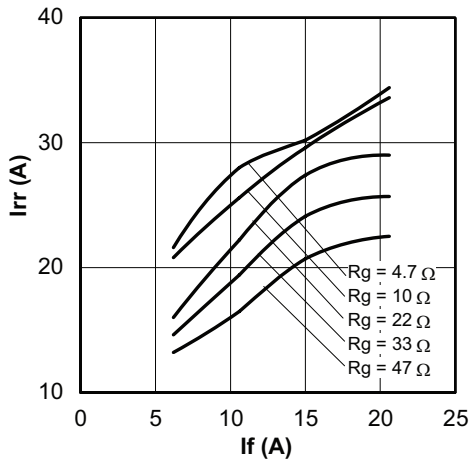


Fig. 32 - Typical Diode  $I_{RR}$  vs.  $I_F$   
 $T_J = 125^\circ\text{C}$

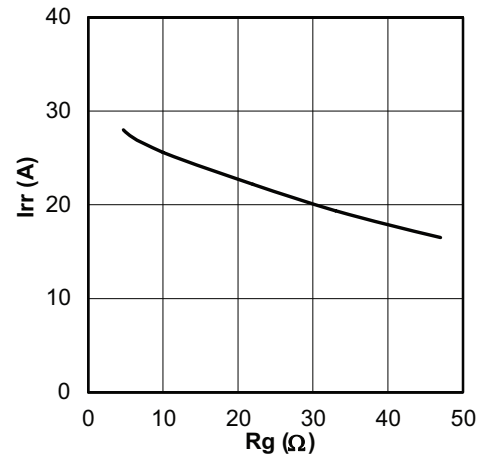


Fig. 33 - Typical Diode  $I_{RR}$  vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $I_F = 10\text{ A}$

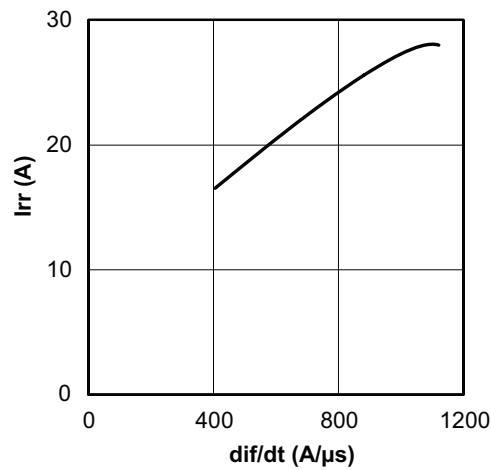


Fig. 34 - Typical Diode  $I_{RR}$  vs.  $di_F/dt$   
 $V_{CC} = 300\text{ V}$ ;  $V_{GE} = 15\text{ V}$ ;  $I_{CE} = 10\text{ A}$ ;  $T_J = 125^\circ\text{C}$

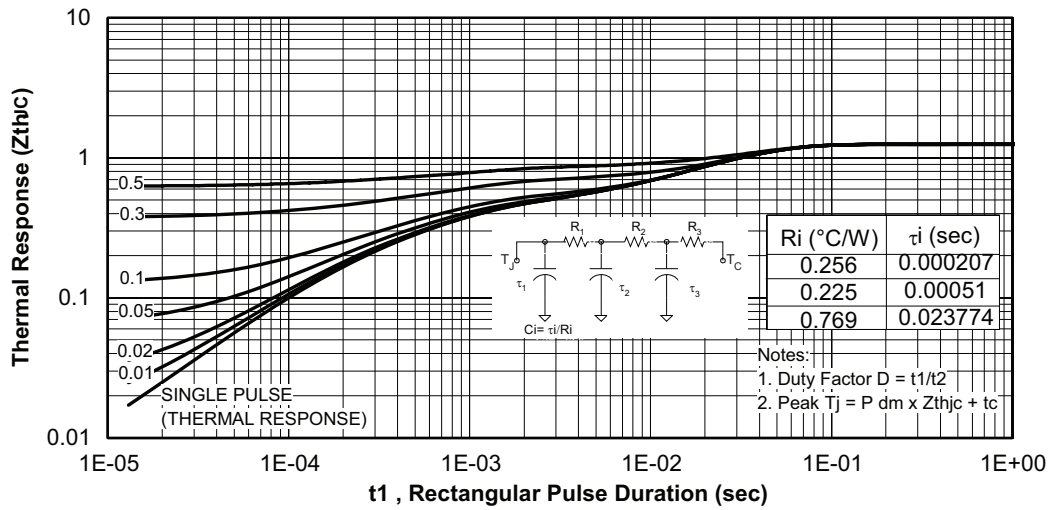


Fig. 35 - Maximum Transient Thermal Impedance, Junction to Case (Brake IGBT)

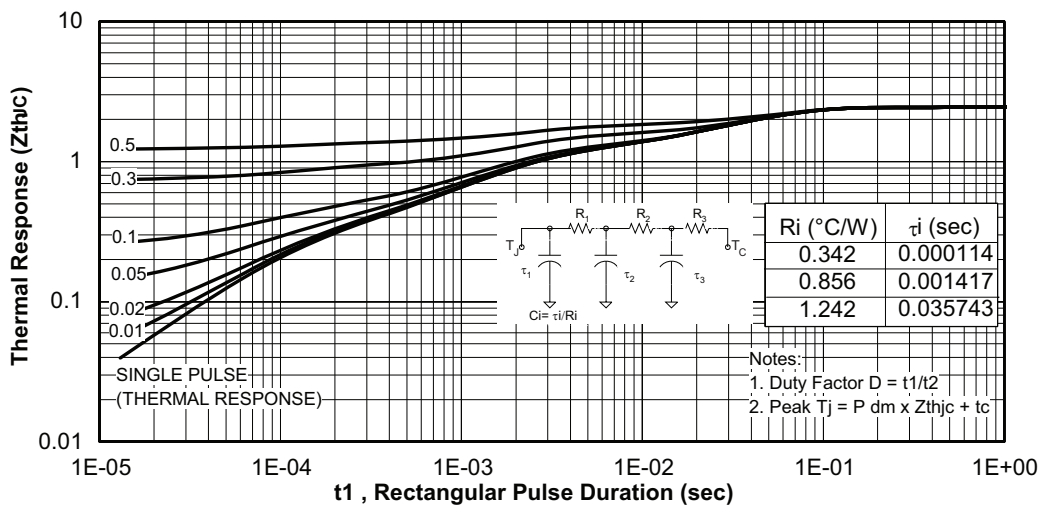


Fig. 36 - Maximum Transient Thermal Impedance, Junction to Case (Brake Diode)

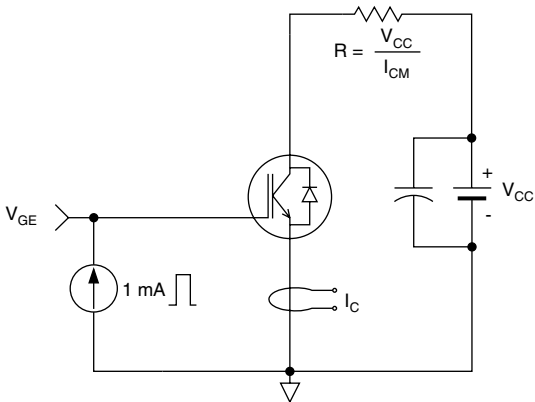


Fig. C.T.1 - Gate Charge Circuit (turn-off)

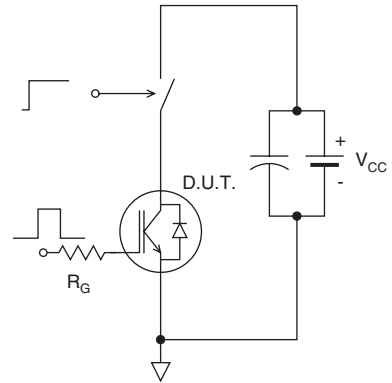


Fig. C.T.3 - S.C. SOA Circuit

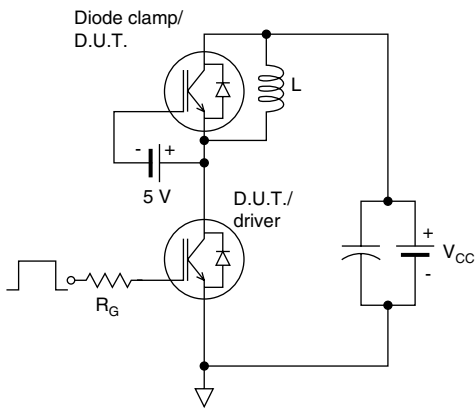


Fig. C.T.2 - RBSOA Circuit

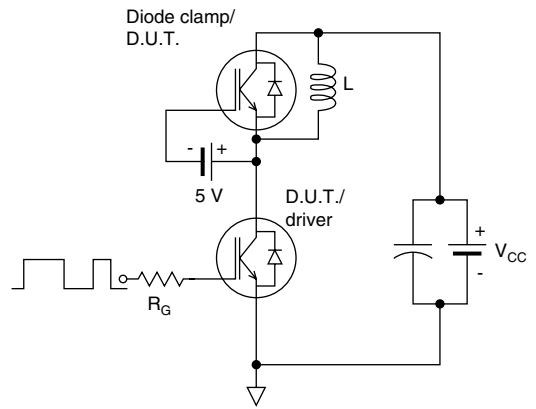


Fig. C.T.4 - Switching Loss Circuit

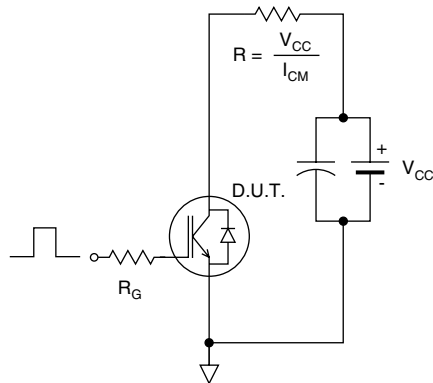
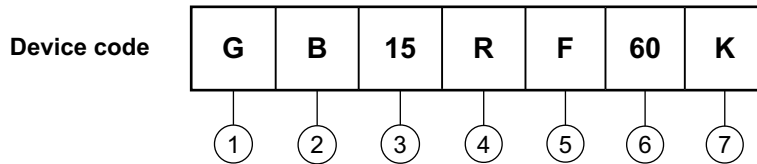


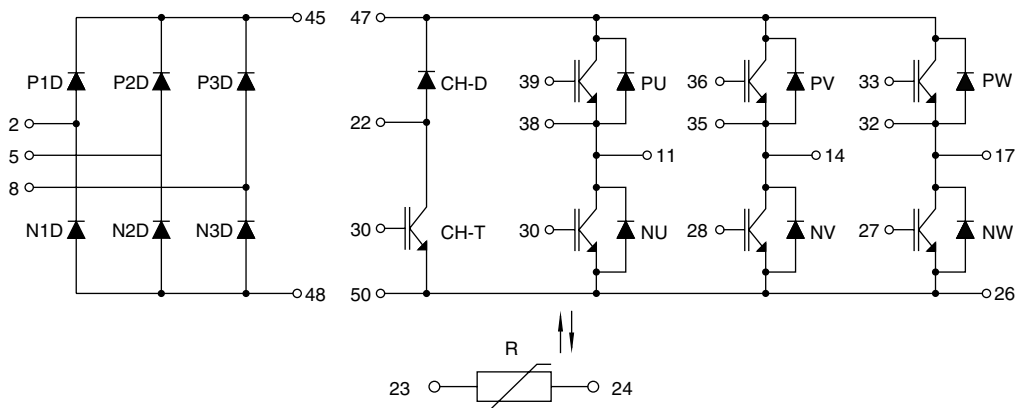
Fig. C.T.5 - Resistive Load Circuit

## ORDERING INFORMATION TABLE



- 1** - Insulated Gate Bipolar Transistor (IGBT)
- 2** - B = IGBT Generation 5 NPT
- 3** - Current rating (15 = 15 A)
- 4** - Circuit configuration  
(R = Three phase bridge-brake-inverter with thermistor)
- 5** - Package indicator (F = ECONO2)
- 6** - Voltage rating (60 = 600 V)
- 7** - Speed/type (K = Ultrafast IGBT/Speed 8 to 60 kHz)

## CIRCUIT CONFIGURATION



### LINKS TO RELATED DOCUMENTS

Dimensions	<a href="http://www.vishay.com/doc?95083">http://www.vishay.com/doc?95083</a>
Part marking information	<a href="http://www.vishay.com/doc?95071">http://www.vishay.com/doc?95071</a>



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